

## PATENT APPLICATION

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FORM PTO-1449	ATTY. DKT NO. 11-164	SER. NO. 10/602,699
APPLICANT TAGUCHI et al.		
FILING DATE June 25, 2003	GROUP 2632	

REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

## FOREIGN PATENT DOCUMENTS

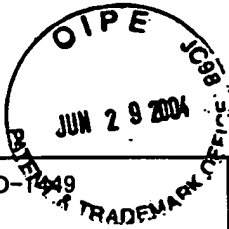
								TRANSLATION	
		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
D.W.B.		JP-A-2001-357471	12/26/01	JAPAN				Engl. Abstract	

\* Full English text of the JP Document will be available in machine-translated form from JP (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	DATE CONSIDERED	
Davette W. Goble	2/3/05	

Rev. 10/94 (Form 3.05)



Form PTO-1449  PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)  Sheet 1 of <u>1</u>	ATTORNEY DOCKET NO.  <u>11-164</u>	SERIAL NO.  <u>10/602,699</u>
	APPLICANT  <u>Akihiro TAGUCHI et al.</u>	
	FILING DATE  <u>6/29/03</u>	GROUP  <u>2632</u>

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date

FOREIGN PATENT DOCUMENTS							
						Translation	
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Yes	No
	DWG	3-33381	2/13/91	Japan	_____	X	
	↓	6-195582	7/15/94	Japan	_____	X	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc. )		
Ref. Desig.	Examiner's Initials	

EXAMINER: <u>Douglas W. How</u>	Date Considered: <u>2/3/05</u>
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EXAMINER: Please initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	11-164	10/602,699
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	June 25, 2003	2632

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
	DWB	5,602,524	2/11/97	Mock et al. (corres. to JP3212311)		
		6,271,748	8/7/01	Derbyshire		
	↓	6,545,599	4/8/03	Derbyshire		

FOREIGN PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation	
						Yes	No
	DWB	3212311	7/19/01	Japan Mock et al.			

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
Ref. Desig.	Examiner's Initials	

EXAMINER: <u>Davette Williams</u>	Date Considered: <u>2/3/05</u>
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